

<b>Notice of References Cited</b>	Application/Control No. 10/712,202		Applicant(s)/Patent Under Reexamination HUEBNER ET AL.	
	Examiner DEVANIE DUFOUR		Art Unit 3733	Page 1 of 2

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	Examiner DEVANIE DUFOUR		Art Unit 3733	Page 2 of 2

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